

**I. Power section**

Absolute maximum ratings		$T_s = 25^\circ\text{C}$ unless otherwise specified		
Symbol	Conditions	Values	Units	
IGBT				
$V_{CES}^{(1)}$	Operating DC link voltage	1200 900 $\pm 20$	V	
$V_{GES}$			V	
$I_c$	$T_s = 25 \text{ (70) } ^\circ\text{C}$	2400 (1800)	A	
Inverse diode				
$I_F = -I_c$	$T_s = 25 \text{ (70) } ^\circ\text{C}$	1800 (1335)	A	
$I_{FSM}$	$T_j = 150 \text{ } ^\circ\text{C}, t_p = 10\text{ms}; \sin$	17280	A	
$I^2t$ (Diode)	Diode, $T_i = 150 \text{ } ^\circ\text{C}, 10\text{ms}$	1493	kA <sup>2</sup> s	
$T_j, (T_{stg})$		-40...+150 (125)	°C	
$V_{isol}$	rms, AC, 1min per AC terminal, rms, $T_s = 70^\circ\text{C}, T_{terminal} < 115^\circ\text{C}$	3000	V	
$ I_{AC\text{-terminal}}$		400	A	

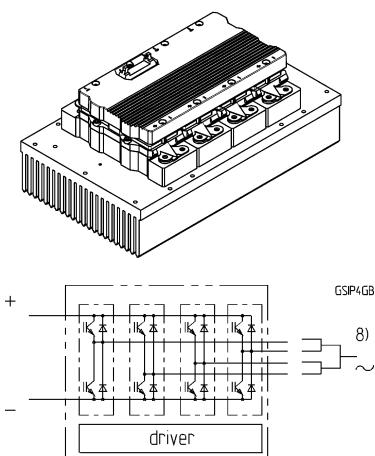
**Characteristics**  $T_s = 25^\circ\text{C}$  unless otherwise specified

Symbol	Conditions	min.	typ.	max.	Units
IGBT					
$V_{CEsat}$	$I_c = 1200\text{A}, T_j = 25 \text{ (125) } ^\circ\text{C};$ measured at terminal	–	1,7 (1,9)	2,1	V
$V_{CEO}$	$T_j = 25 \text{ (125) } ^\circ\text{C};$ at terminal	–	0,9 (0,8)	1,1 (1,0)	V
$r_{CE}$	$T_j = 25 \text{ (125) } ^\circ\text{C};$ at terminal	–	0,7 (0,9)	0,9 (1,2)	mΩ
$I_{CES}$	$V_{GE}=0, V_{CE}=V_{CES}, T_j=25(125) \text{ } ^\circ\text{C}$	–	4,8 (144)	–	mA
$E_{on} + E_{off}$	$I_c=1200\text{A}, V_{cc}=600\text{V}$ $T_j=125^\circ\text{C}$	–	456	–	mJ
$L_{CE}$	top, bottom	–	3	–	nH
$C_{CHC}$	per phase, AC side	–	6,8	–	nF
$R_{CC\text{-EE}}$	terminal-chip, $T_j=25 \text{ } ^\circ\text{C}$	–	0,13	–	mΩ
Inverse diode					
$V_F = V_{EC}$	$I_F=1200\text{A}; T_j = 25(125) \text{ } ^\circ\text{C}$ measured at terminal	–	1,5 (1,5)	1,8	V
$V_{TO}$	$T_j = 25 \text{ (125) } ^\circ\text{C}$	–	0,9 (0,7)	1,1 (0,9)	V
$r_T$	$T_j = 25 \text{ (125) } ^\circ\text{C}$	–	0,5 (0,7)	0,6 (0,8)	mΩ
$E_{RR}$	$I_c=1200\text{A}, V_{cc}=600\text{V}$ $T_j=125^\circ\text{C}$	–	84	–	mJ
–		–	112	–	mJ
Mechanical data					
$M_{dc}$	DC terminals, SI Units	6	–	8	Nm
$M_{ac}$	AC terminals, SI Units	13	–	15	Nm
w	SKiiP® 3 System w/o heat sink	–	3,1	–	kg
w	heat sink	–	9,7	–	kg
Thermal characteristics (PX16 heat sink with fan SKF16B-230-1); "s" reference to heat sink; "r" reference to built-in temperature sensor (acc. IEC 60747-15)					
$R_{thjsIGBT}$	per IGBT	–	–	0,015	°C/W
$R_{thjsdiode}$	per diode	–	–	0,029	°C/W
$Z_{th}$	$R_i (\text{mK/W})$ (max. values)			tau(s)	
	1      2      3      4	1	2	3	4
$IGBT_{jr}$	5,6    6,0    6,4    0,0	363,0	0,18	0,04	1,0
diode <sub>jr</sub>	10,0    8,4    14,8    14,8	50,0	5,0	0,25	0,04
heatsink <sub>ra</sub>	3,1    17,3    3,7    0,9	230	78	13,0	0,4

**SKiiP® 3****SK integrated intelligent Power 2-pack****SKiiP 2413GB123-4DL**

## Preliminary data

## Case S43

**Features**

- SKiiP technology inside
- Trench IGBTs
- CAL HD diode technology
- integrated current sensor
- integrated temperature sensor
- integrated heat sink
- IEC 60721-3-3 (humidity) class 3K3/IE32 (SKiiP® 3 System)
- IEC 68T.1 (climate) 40/125/56 (SKiiP® 3 power section)
- UL recognized File no. E63532 (SKiiP® 3 power section)

- 1) with assembly of suitable MKP capacitor per terminal (SEMIKRON type is recommended)
- 8) AC connection busbars must be connected by the user; copper busbars available on request

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# SKiiP 2413GB123-4DL

**SKiiP 3®**

**SK integrated intelligent Power**

**SKiiP 2413GB123-4DL**

Preliminary data

## Gate driver features

- CMOS compatible inputs
- wide range power supply
- integrated circuitry to sense phase current, heat sink temperature and DC-bus voltage (option)
- short circuit protection
- over current protection
- over voltage protection (option)
- power supply protected against under voltage
- interlock of top/bottom switch
- isolation by transformers
- fibre optic interface (option for GB-types only)
- IEC 68T.1 (climate) 40/85/56 (SKiiP® 3 gate driver)

## II. Integrated gate driver

### Absolute maximum ratings

Symbol	Term	Value	Unit
$V_{S2}$	Unstabilized 24V power supply	30	V
$V_{iH}$	Input signal voltage (high)	15 + 0,3	V
$dv/dt$	Secondary to primary side	75	kV/μs
$V_{isoIO}$	Input / output (AC, rms, 2 s)	3000	V
$V_{isoPD}$	Partial discharge extinction voltage, rms, $Q_{PD} \leq 10 \text{ pC}$ ;	1170	V
$V_{isol12}$	Output 1 / output 2 (AC, rms, 2s)	1500	V
$f$	Switching frequency	6	kHz
$T_{op}$ ( $T_{stg}$ )	Operating / storage temperature	- 40 ... + 85	°C

### Electrical characteristics ( $T_a = 25^\circ\text{C}$ )

Symbol	Term	min	typ	max.	Units
$V_{S2}$	Supply voltage non stabilized	13	24	27	V
$I_{S2}$	$V_{S2} = 24\text{V}$	$324 + 50*f / \text{kHz} + 0,00011 * (I_{AC}/A)^2$			mA
$V_{iT+}$	Input threshold voltage (High)	11,2	—	—	V
$V_{iT-}$	Input threshold voltage (Low)	—	—	5,4	V
$R_{in}$	Input resistance	—	10	—	kΩ
$C_{in}$	Input capacitance	—	1	—	nF
$t_{d(on)IO}$	input-output turn-on propagation time	—	1,1	—	μs
$t_{d(off)IO}$	input-output turn-off propagation time	—	1,1	—	μs
$t_pERRRESET$	error memory reset time	—	9	—	μs
$t_{TD}$	top/bottom switch: interlock time	—	3,3	—	μs
$I_{analogOUT}$	max. 5mA ; 8 V corresponds to 15 V supply voltage for external components; max load current	—	2400	—	A
$I_{S1out}$		—	—	50	mA
$I_{TRIPSC}$	over current trip level ( $I_{analog OUT} = 10\text{V}$ )	—	3000	—	A
$T_{tp}$	over temperature protection	110	—	120	°C
$U_{DCTRIP}$	$U_{DC}$ -protection ( $U_{analog OUT} = 9\text{V}$ ) (option for GB types)	not implemented	—	—	V

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